

<b>Notice of References Cited</b>	Application/Control No. 10/056,437	Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Shun Lee	Art Unit 2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Romero et al. "An analytical model for the photodetection mechanisms in high electron mobility transistors", IEEE Transactions on Microwave Theory and Techniques, Vol. 44, no. 12, (December 1996), pp. 2279-2287.
	V	
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